# Power MOSFET 20 V, 5.6 A Single **N-Channel, TSOP-6**

#### **Features**

- Leading Edge Trench Technology for Low On Resistance
- Low Gate Charge for Fast Switching
- Small Size (3 x 2.75 mm) TSOP-6 Package
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and **PPAP** Capable
- This is a Pb-Free Device

## **Applications**

- DC-DC Converters
- Lithium Ion Battery Applications
- Load/Power Switching

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating			Symbol	Value	Unit	
Drain-to-Source Voltage			V <sub>DSS</sub>	20	V	
Gate-to-Source Voltage	Gate-to-Source Voltage			±8	٧	
	Steady	T <sub>A</sub> = 25°C		5.6		
Continuous Drain Current (Note 1)	State	T <sub>A</sub> = 85°C	$I_{D}$	4.1	А	
	t ≤ 10 s	T <sub>A</sub> = 25°C		6.2		
Power Dissipation	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.1	w	
(Note 1)	t ≤ 10 s	, ,	J	1.4		
Continuous Drain Current		T <sub>A</sub> = 25°C		4.2	^	
(Note 2)	Steady	T <sub>A</sub> = 85°C	I <sub>D</sub>	3.0	Α	
Power Dissipation (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.6	W	
Pulsed Drain Current	t <sub>P</sub> s	I <sub>DM</sub>	19	Α		
Operating and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	
Source Current (Body Diode)			IS	1.0	Α	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C	

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)		110	
Junction-to-Ambient - t ≤ 10 s (Note 1)	$R_{\theta JA}$	90	°C/W
Junction-to-Ambient - Steady State (Note 2)		200	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size

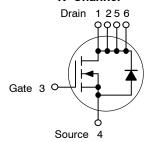


# ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> mAX	I <sub>D</sub> Max	
20 V	24 mΩ @ 4.5 V	5.6 A	
	32 mΩ @ 2.5 V	4.9 A	

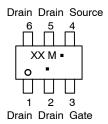
#### N-Channel



# **MARKING DIAGRAM & PIN ASSIGNMENT**



**CASE 318G** STYLE 1



= Specific Device Code XX

М = Date Code\*

= Pb-Free Package (Note: Microdot may be in either location)

\*Date Code orientation may vary depending

upon manufacturing location.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information ion page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Test Co	ondition	Min	Тур	Max	Unit	
OFF CHARACTERISTICS	-			1	11	I		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V;	I <sub>D</sub> = 250 μA	20			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				9.8		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}; V_{DS} = 16 \text{ V}, $ $T_{J} = 25^{\circ}\text{C}$				1.0	μΑ	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0, \	/ <sub>GS</sub> = ±8 V			100	nA	
ON CHARACTERISTICS (Note 3)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS,}$	I <sub>D</sub> = 250 μA	0.4	0.6	1.4	V	
Negative Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3.4		mV/°C	
David In Co. and Co. Basistana	5	V <sub>GS</sub> = 4.5 \	/, I <sub>D</sub> = 5.6 A		19	24	mΩ	
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 2.5 \	/, I <sub>D</sub> = 4.9 A		25	32		
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V	/, I <sub>D</sub> = 5.6 A		8.2		S	
CHARGES, CAPACITANCE, & GATE RES	STANCE							
Input Capacitance	C <sub>ISS</sub>	\/	0.1/		935			
Output Capacitance	C <sub>OSS</sub>	f = 1	= 0 V, MHz,		169		1	
Reverse Transfer Capacitance	C <sub>RSS</sub>	V <sub>DS</sub> = 16 V			104		1	
Input Capacitance	C <sub>ISS</sub>	\/	0.)/		965		pF	
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V},$ f = 1  MHz, $V_{DS} = 10 \text{ V}$			198			
Reverse Transfer Capacitance	C <sub>RSS</sub>				110			
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V V <sub>DS</sub> = 16 V I <sub>D</sub> = 5.6 A			13.2	20.3	nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.60			
Gate-to-Source Charge	Q <sub>GS</sub>				1.5			
Gate-to-Drain Charge	$Q_{GD}$				4.2			
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V V <sub>DS</sub> = 5.0 V I <sub>D</sub> = 6.2 A			11.8	18.0		
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.6			
Gate-to-Source Charge	Q <sub>GS</sub>				1.4			
Gate-to-Drain Charge	Q <sub>GD</sub>	_			2.7		1	
SWITCHING CHARACTERISTICS, V <sub>GS</sub> = 4	1.5 V (Note 4)				-1	I	· I	
Turn-On Delay Time	t <sub>d(ON)</sub>				6.3	12.6		
Rise Time	t <sub>r</sub>	$\begin{array}{c} V_{GS}=4.5 \text{ V,} \\ V_{DD}=16 \text{ V,} \\ I_{D}=1 \text{ A,} \\ R_{G}=3 \Omega \end{array}$			7.3	13.5	ns	
Turn-Off Delay Time	t <sub>d(OFF)</sub>				21.7	35.1		
Fall Time	t <sub>f</sub>				9.7	17.6		
DRAIN-SOURCE DIODE CHARACTERIST	ics			<u> </u>	ı			
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.0 A	T <sub>J</sub> = 25°C		0.7	1.2	V	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 Vdc, $dI_{SD}/dt$ = 100 A/ $\mu$ s, $I_{S}$ = 1.0 A			20.4			
Charge Time	ta				8.1		ns	
Discharge Time	t <sub>b</sub>				11.6		=	
Reverse Recovery Charge	Q <sub>RR</sub>				8.8		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperature.

#### TYPICAL CHARACTERISTICS

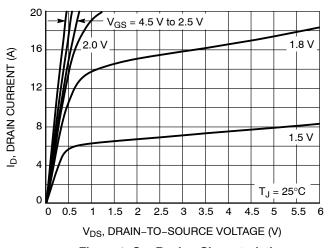


Figure 1. On-Region Characteristics

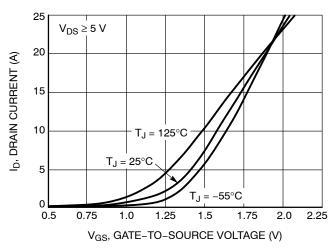


Figure 2. Transfer Characteristics

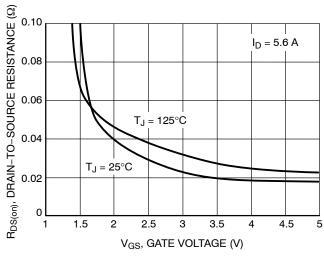


Figure 3. On-Resistance vs. Gate-to-Source Voltage

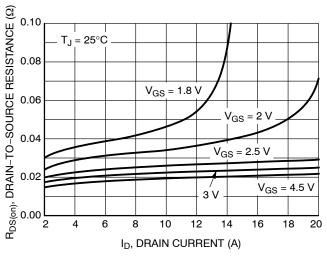


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

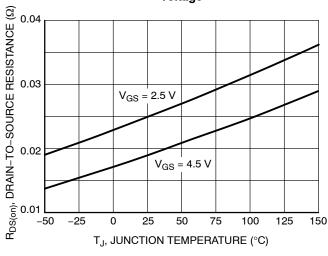


Figure 5. On–Resistance Variation with Temperature

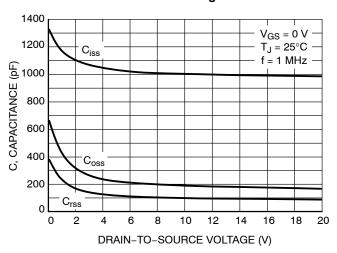


Figure 6. Capacitance Variation

#### **TYPICAL CHARACTERISTICS**

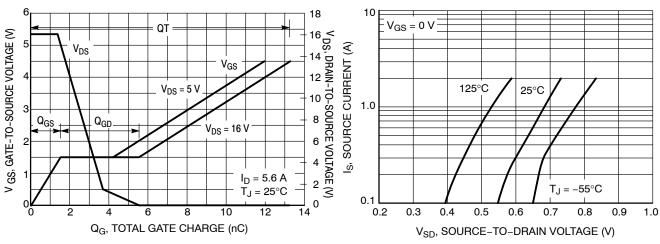


Figure 7. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

Figure 8. Diode Forward Voltage vs. Current

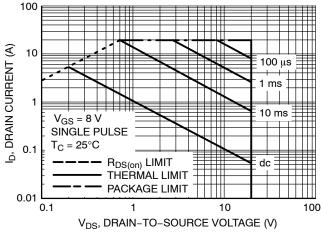


Figure 9. Maximum Rated Forward Biased Safe Operating Area

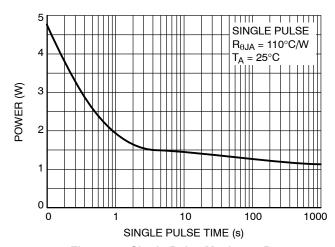


Figure 10. Single Pulse Maximum Power Dissipation

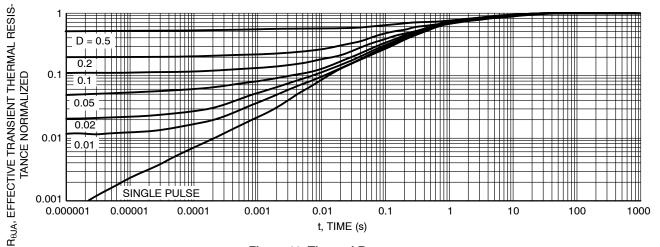


Figure 11. Thermal Response

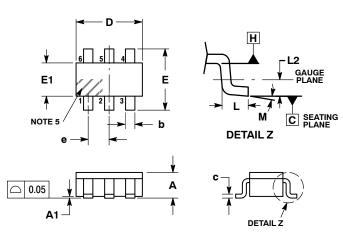
**Table 1. ORDERING INFORMATION** 

Part Number	Marking (XX)	Package	Shipping <sup>†</sup>
NTGS3130NT1G	S9	TSOP-6 (Pb-Free)	3000 / Tape & Reel
NVGS3130NT1G	VS9	TSOP-6 (Pb-Free)	3000 / Tape & Reel

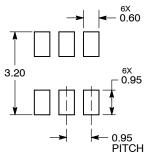
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# PACKAGE DIMENSIONS

#### TSOP-6 CASE 318G-02 ISSUE V



## **RECOMMENDED SOLDERING FOOTPRINT\***



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM
- LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
  DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR GATE BURRS, MOLD FLASH, PROTRUSIONS, OR
  GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
  5. PIN ONE INDICATOR MUST BE LOCATED IN THE INDICATED ZONE.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.01	0.06	0.10	
b	0.25	0.38	0.50	
С	0.10	0.18	0.26	
D	2.90	3.00	3.10	
E	2.50	2.75	3.00	
E1	1.30	1.50	1.70	
е	0.85	0.95	1.05	
L	0.20	0.40	0.60	
L2	0.25 BSC			
М	0°	-	10°	

#### STYLE 1:

PIN 1. DRAIN 2. DRAIN

- 3 GATE
- 4. SOURCE
- DRAIN
- 6. DRAIN

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